

ECE 622 (ESS)

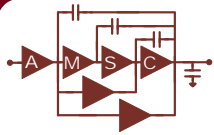
Fall 2011



Design of Linear OTA-C Filters over Wide Frequency Ranges

*Courtesy of
Mohamed Mobarak
Marvin Onabajo*

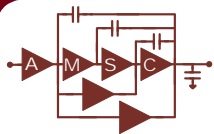
**Analog & Mixed-Signal Center
Dept. of Electrical & Computer Engineering
Texas A&M University**



Outline



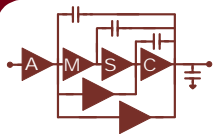
- Introduction
 - Motivation and objectives
 - Linearization Schemes
- Attenuation-Predistortion Linearization for Operational Transconductance Amplifiers (OTAs)
 - Proposed approach
 - Single-ended OTAs
 - Differential OTAs
- Application to OTA-C Filters
 - Low-pass filter example
 - Measurement results
 - Comparison with the state of the art
- Advanced Concepts
 - Excess phase compensation
 - Linearization without power budget increase
- Summary & Conclusions



Operational Transconductance Amplifier Linearization



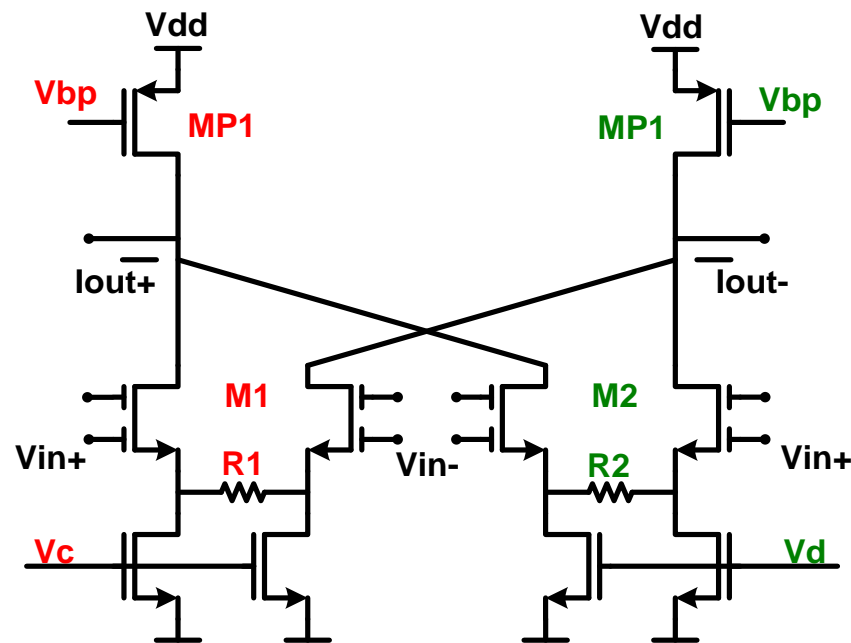
- Project objective
 - Improved cancellation of OTA non-linearities
 - Method: distortion created in an identical auxiliary path → subtracted from main signal
- Motivation
 - Robustness of linearization to process variations
 - Compensation for frequency-dependent linearity degradation
- Applications with operational transconductance amplifiers (OTAs)
 - On-chip filters in the 100-200MHz frequency range
 - ♦ In high-IF stage of wireless receivers
 - ♦ Bandpass Continuous-time $\Sigma\Delta$ A/D converters (SNDR > 70dB)
 - Transconductance-capacitor baseband filters
 - ♦ Third-order intermodulation distortion (IM3) < -60dB
 - ♦ $f < 50\text{MHz}$ (ex. xDSL, WLAN, WCDMA, UMTS)

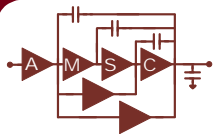


Linearization Schemes



- Cross coupled differential pair
 - Sensetive to PVT variations
- Source degeneration
 - Decrease the effective transconductance and the available headroom
 - Increase the noise due to lower transconductance and addition of resistors
- Signal attenuation
 - Decrease the effective transconductance
 - Increase the input referred noise
- Combination of Cross-Coupling Cancellation, Floating-Gate Attenuation, Source Degeneration





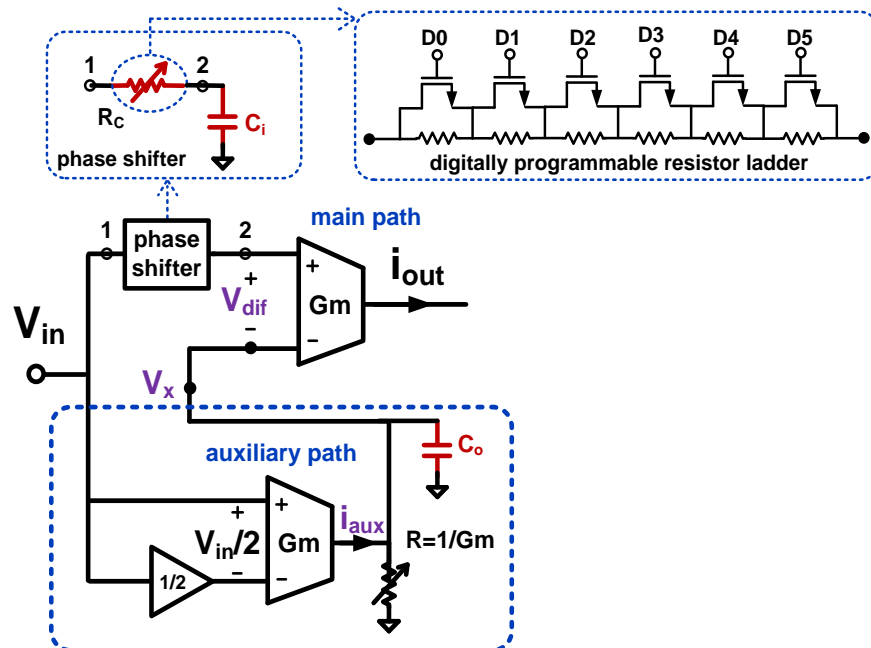
Proposed Attenuation-Predistortion Linearization



- Single-ended OTAs
- Effective transconductance
 - $G_{m_{\text{eff}}} = \frac{1}{2} G_m$ of non-linearized OTA with input-attenuation factor of 0.5
 - Same dimensions & bias in both paths
- Conditions for cancellation
 - $G_m \times R = 1$ in aux. path
 - $R_c \approx R$ for optimum cancellation
 - R_c & C_i give **1st-order frequency compensation**
→ pole frequency $\approx 1/R_c C_i$ → phase shift

Advantages

- Even with the presence of 10% Mismatch 20dB cancellation can be obtained
- In the presence of 1% mismatch the cancellation can be as much as 40dB



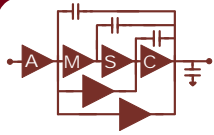
$$i_{\text{aux}} = G_m V_{\text{in}}/2 + i_{\text{non-lin}}\{V_{\text{in}}/2\}$$

$$V_x = V_{\text{in}}/2 + i_{\text{non-lin}}\{V_{\text{in}}/2\} \times R$$

$$V_{\text{dif}} = V_{\text{in}}/2 - i_{\text{non-lin}}\{V_{\text{in}}/2\} / G_m$$

$$i_{\text{out}} \approx G_m V_{\text{in}}/2 + i_{\text{non-lin}}\{V_{\text{in}}/2\} - i_{\text{non-lin}}\{V_{\text{in}}/2\}$$

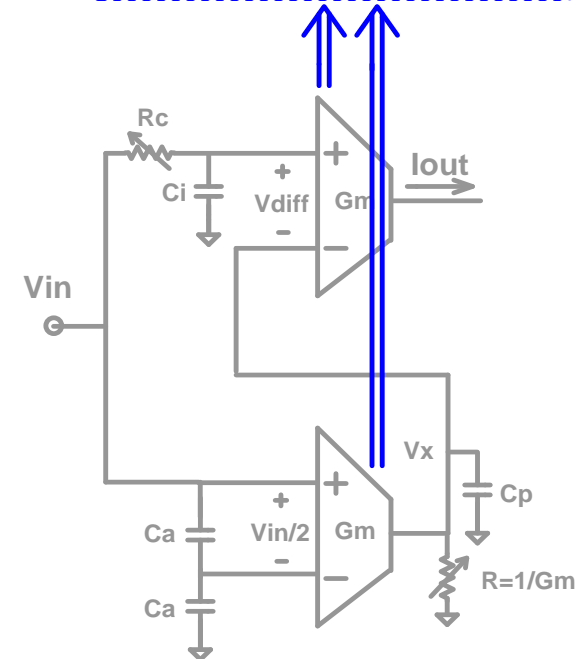
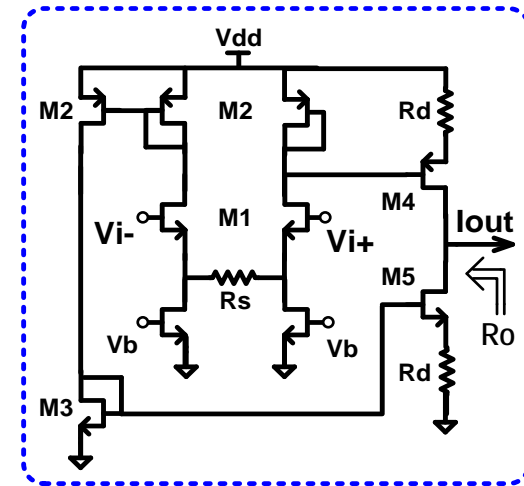
* $i_{\text{non-lin}}\{V_m\}$ represents the distortion components of the current generated by G_m with input voltage amplitude V_m



Single-Ended OTA for High-Frequencies



- Topology modified from 3-current mirror OTA
 - No cascode output stage
 - ♦ Stacked devices are less effective with 1.2V supply
 - ♦ Min. lengths (min. capacitance) for 100MHz operation
→ r_{out} of transistors as low as 1.5k Ω
 - Modified OTA
 - ♦ Similar output resistance as cascode (0.13 μ m tech.)
 - ♦ More linear with large signal swings

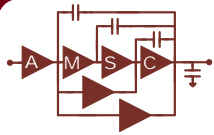


- Basic specs →
(0.13 μ m CMOS,
1.2V supply)

Parameter	Value
Gm	776 μ A/V
Excess Phase	2.6° at 100MHz
R _o	13k Ω
Gain Bandwidth Product	622MHz
Power	2.4mW



Fully-Differential OTA Linearization



- Fully differential architecture offer many advantages over single ended circuits
- Generalized conditions for attenuation-predistortion linearization

▪ Non-linearity cancellation:

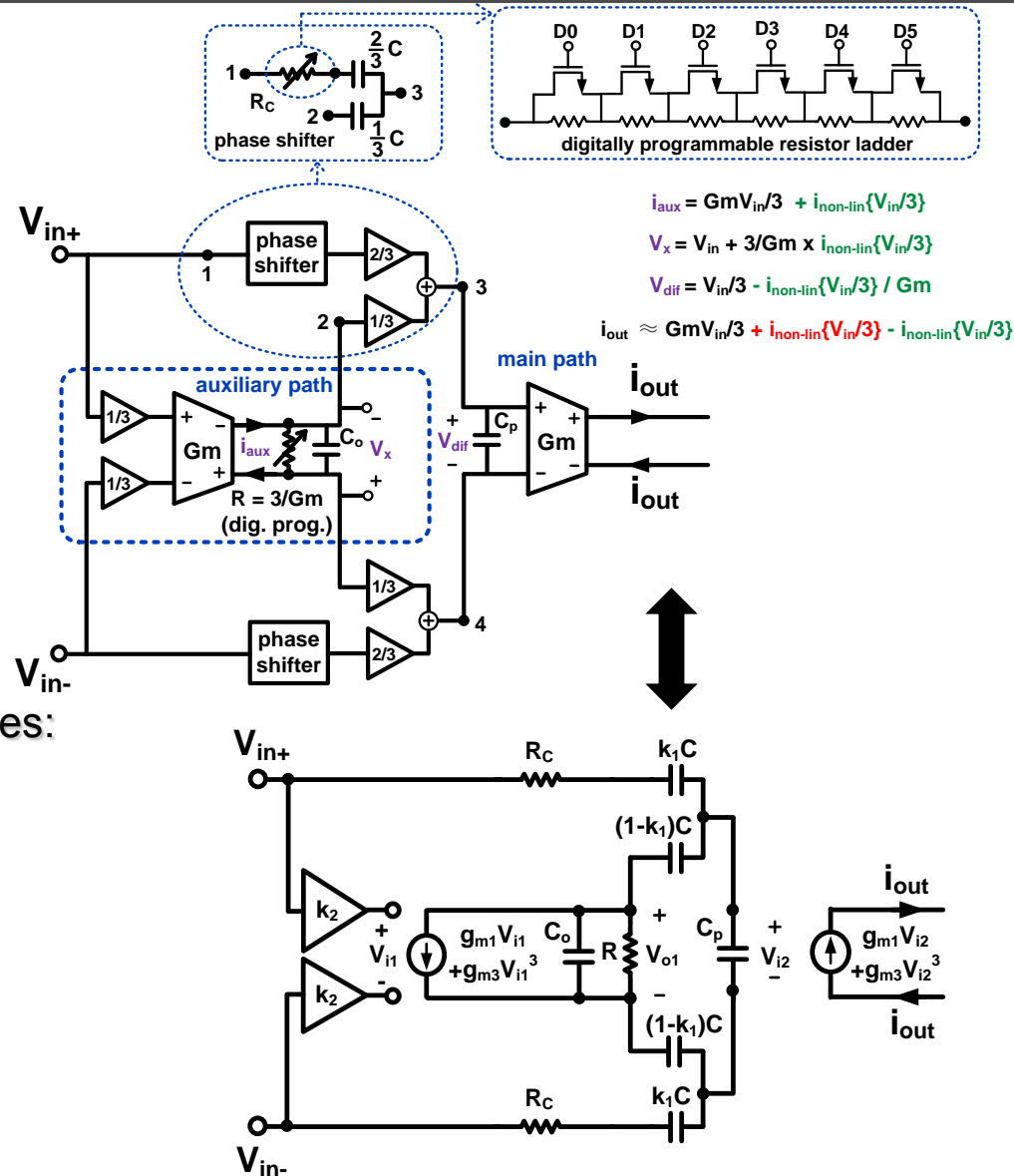
$$(1 - k_1)G_m R = 1 \quad , \quad k_2 = k_1 / 2$$

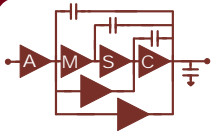
$$G_{m_eff} = k_2 G_m \quad k_2 G_m R \leq 1$$

- To ensure $IM3 \approx 0$ based on Volterra series:

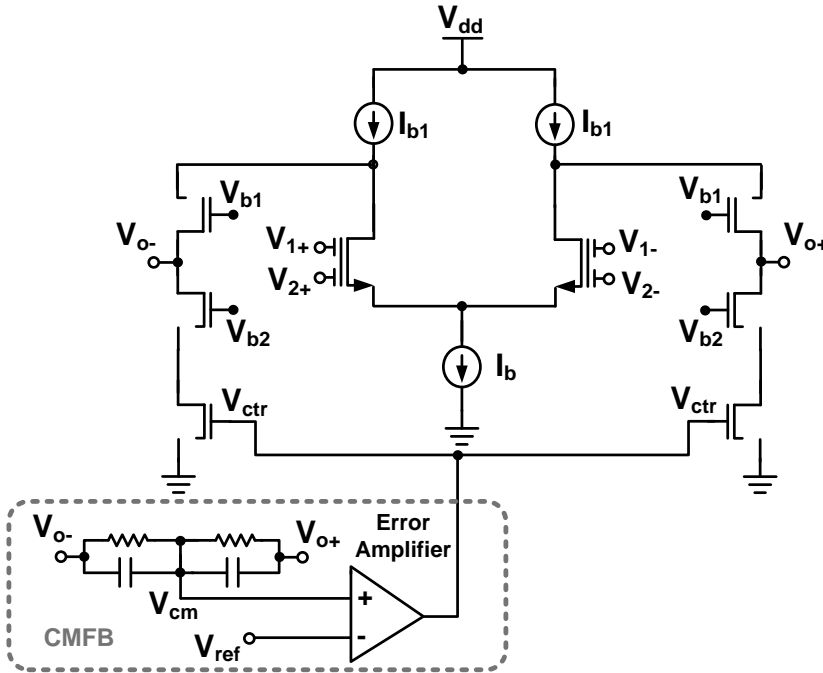
$$R_c \approx \frac{(1 - k_1) + 2C_o / C}{2k_1} R$$

- This design: $k_1 = 2/3$, $k_2 = 1/3$
 $\rightarrow R_c = (R/4) * (1 + 6C_o / C)$





Fully-Differential OTA



Folded-cascode OTA

(implements G_m in main and auxiliary paths)

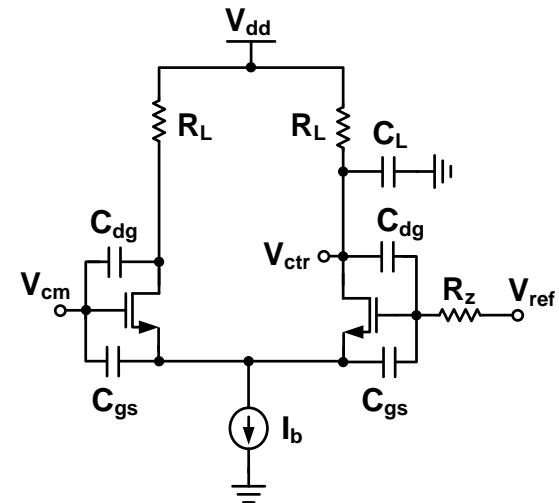
- Error amplifier compensation with resistor R_z in CMFB improves extends the bandwidth of the common-mode rejection:

$$GBW \approx \sqrt{A_0 \cdot \omega_{p1} \cdot \omega_{p3}} \approx \sqrt{A_0 \cdot \omega_{p3} \cdot \frac{2}{R_z (C_{gs} / 2 + (g_m R_L / 2) C_{dg})}}$$

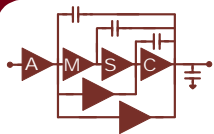
- Affect of R_z on stability according to phase margin (PM):

$$PM \approx \tan^{-1} \left(\sqrt{\frac{2 R_z C_{dg}^2}{A_0 \cdot \omega_{p3} \cdot (C_{gs} / 2 + (g_m R_L / 2) C_{dg})}} \right)$$

Parameter	Measurement
Transconductance (G_m)	510 μ A/V
IM3 @ 50MHz ($V_{in} = 0.2$ Vp-p)	-55.3 dB
Noise (input-referred)	13.3 nV/ \sqrt Hz
Power with CMFB	2.6 mW
PSRR @ 50MHz	48.9 dB
Supply	1.2 V



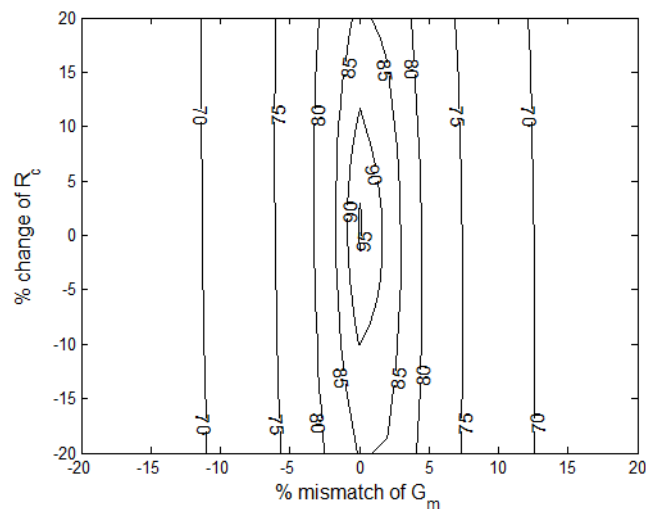
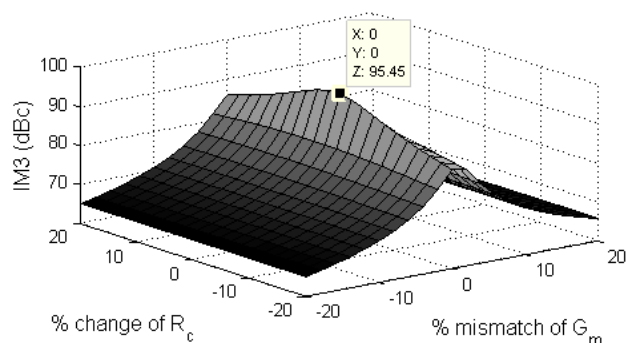
Error amplifier circuit in the common-mode feedback (CMFB) loop



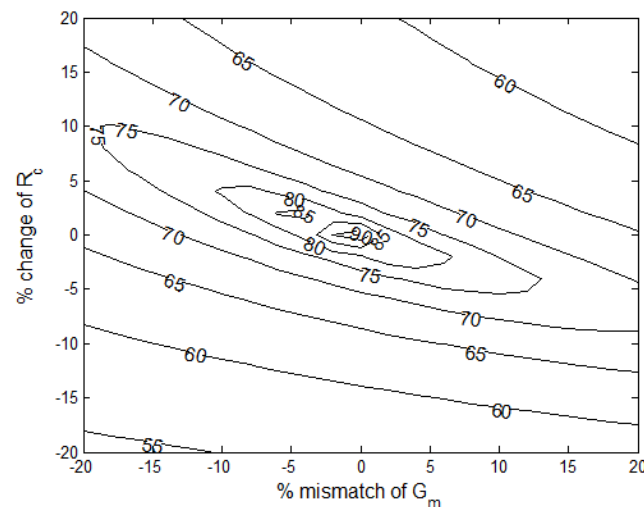
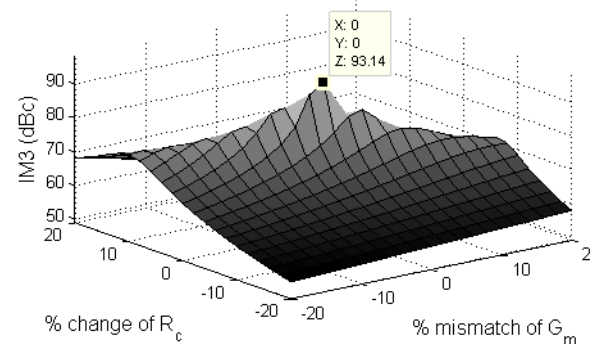
High-Frequency Effects & Process Variation



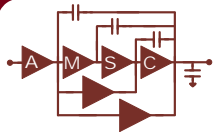
- Theoretical IM3 higher than 70dBc with up to $\pm 10\%$ variation of G_m and $\pm 5\%$ of R_c
 - Can be ensured by matching devices in the layout
 - Robustness verified with schematic corner and component mismatch simulations
- Sensitivity of IM3 (in dBc) to component mismatches:



10MHz signal frequency



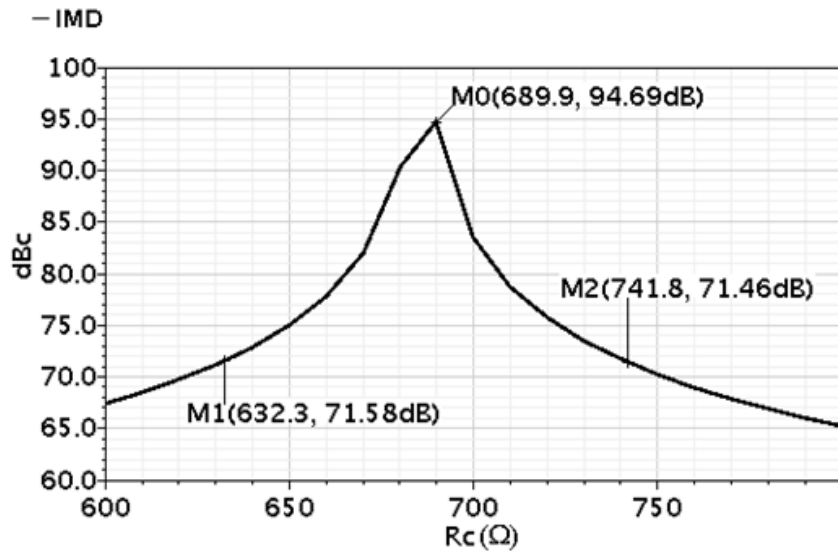
200MHz signal frequency



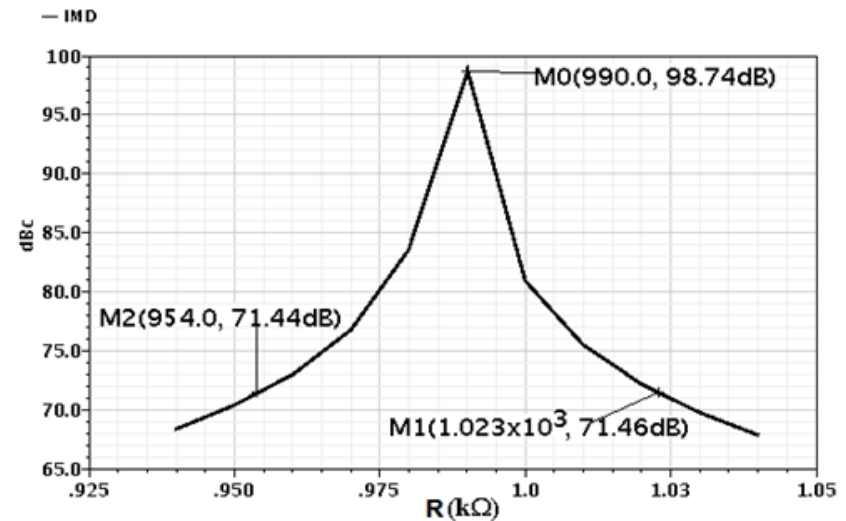
Simulated Fully-Diff. OTA: Mismatch of Critical Components



- IM3 better than 71dBc for $\pm 7.5\%$ R_c -variation
- IM3 better than 71dBc for $\pm 3.3\%$ R -variation in the presence of 10% G_m -mismatch
- Reference OTA has IM3 of 51dBc



IM3 vs. change in R_c at 350MHz



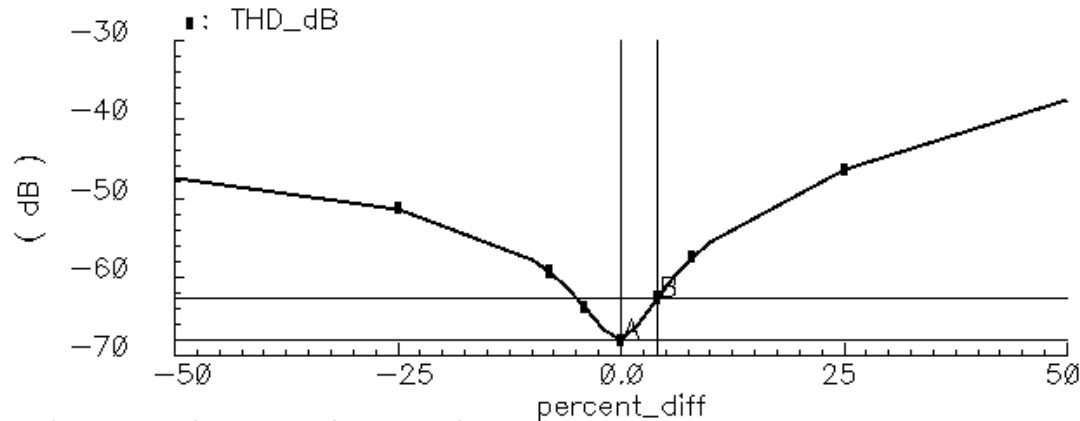
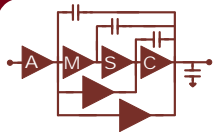
IM3 vs. R with 10% transconductance mismatch between main OTA and auxiliary OTA at 350MHz

Theoretical IM3:

$$i_{IM3} \approx g_{m3} \left(\frac{k_1/2}{1+2C_p/C} \right)^3 (3V_{in1}^2 V_{in2}/4) \left(\frac{1+j\omega_1 C((1-k_1)R - k_1 R_c) + 2j\omega_1 C_o R}{1+j\omega_1 b - c\omega_1^2} \right)^2 \left(\frac{1-j\omega_1 C((1-k_1)R - k_1 R_c) - 2j\omega_1 C_o R}{1-j\omega_1 b - c\omega_1^2} \right)^2$$

$$- g_{m3} \left(\frac{k_1/2}{1+2C_p/C} \right)^3 (3V_{in1}^2 V_{in2}/4) \frac{1+j\omega_1 C k_1 R_c}{1+j\omega_1 b - c\omega_1^2}$$

Variation of Resistor R & Calibration

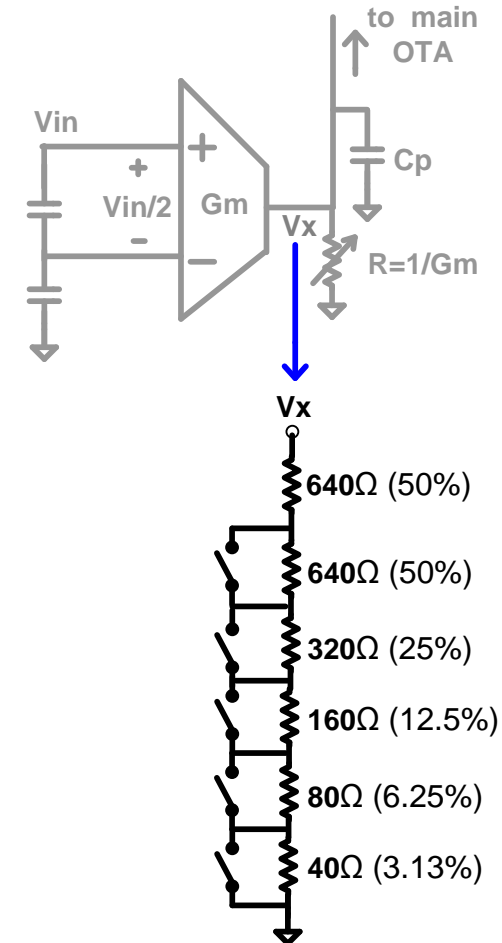


A: (0 -68.1178) delta: (4 5.40391)
 B: (4 -62.7137) slope: 1.35098

THD vs. %-variation of resistor R

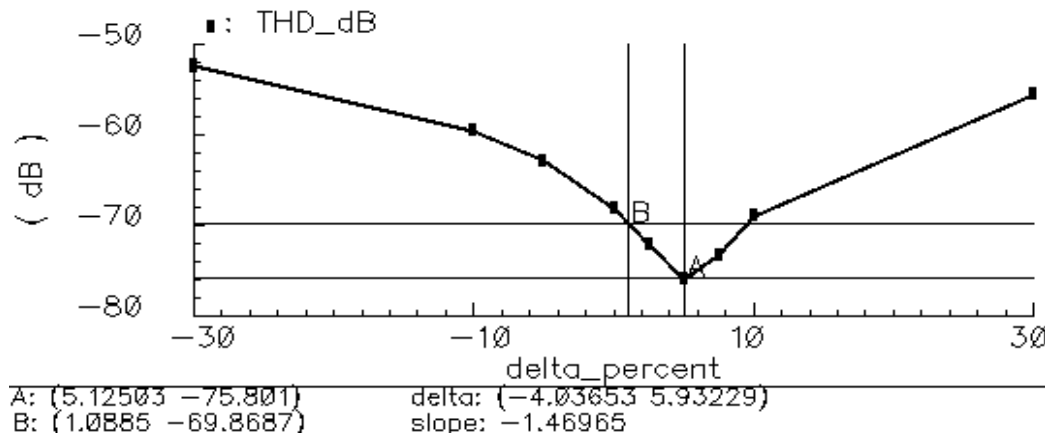
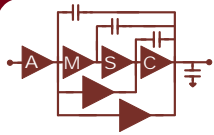
- $\Delta\text{THD} < 5.4\text{dB}$ requires accuracy of R within 4%
- Some form of calibration is necessary
 - Digital (implemented): R can be adjusted with discrete steps until $G_m \times R = 1$
 - Analog tuning also a possibility: comparison of V_{in} and V_x with an error amplifier (V_{peak} , V_{rms} , etc. should be identical), automatic adjustment of R (transistor biased in triode region)

Auxiliary OTA:



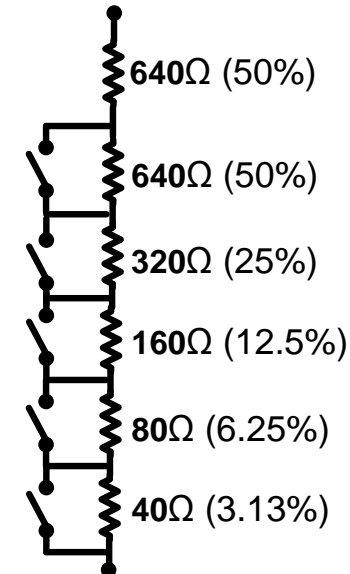
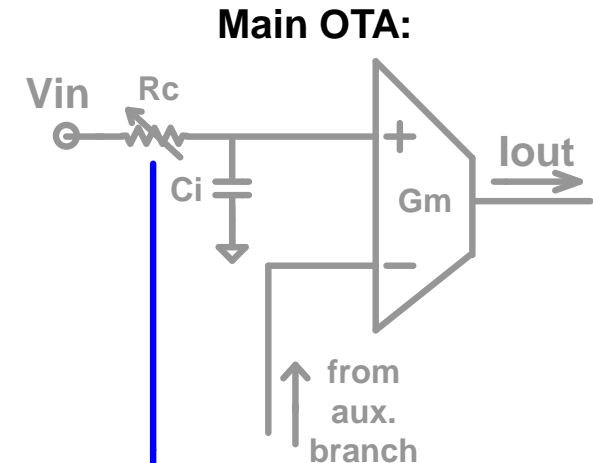
Total $R_c = 1.28\text{k}\Omega$ in this design

Variation of Resistor R_c & Calibration



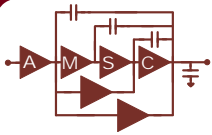
THD vs. %-variation of resistor R_c

- $\Delta\text{THD} < 6\text{dB}$ requires accuracy of R_c within 4%
- Requires same calibration approach as for resistor R
 - Simplest: cycling through switch combinations until optimum linearity
 - Options to assess performance in the digital domain:
 - ◆ Monitor HD3 or THD (if A/D, DSP are available)
 - ◆ In receivers: monitor bit error rate



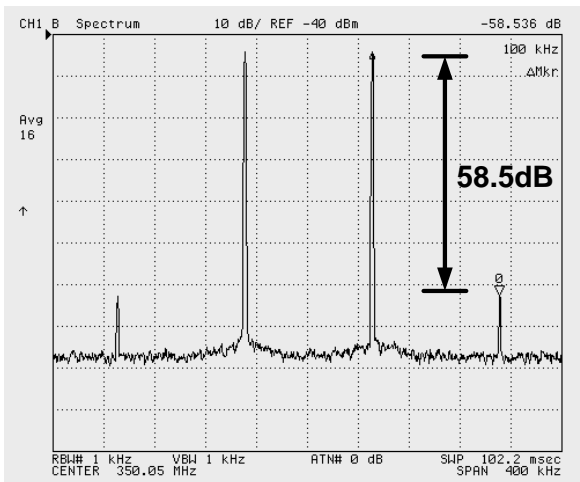
Total $R_c = 1.28\text{k}\Omega$ in this design

Measurements: Fully-Differential OTA

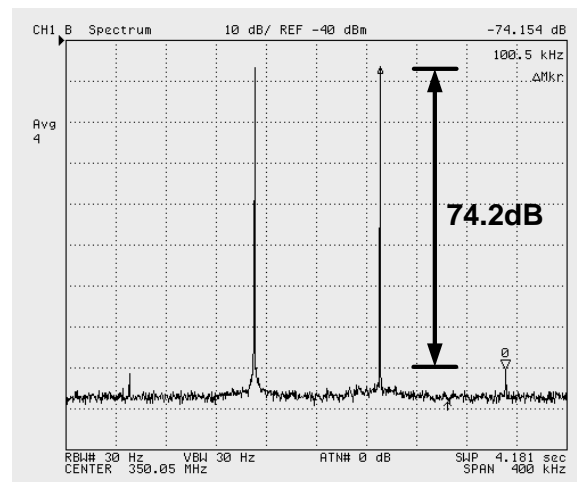


- 0.13 μ m CMOS Testchip
- Fully-differential reference OTAs & linearized fully-differential OTAs
 - 2nd-order low-pass filter with linearized OTAs

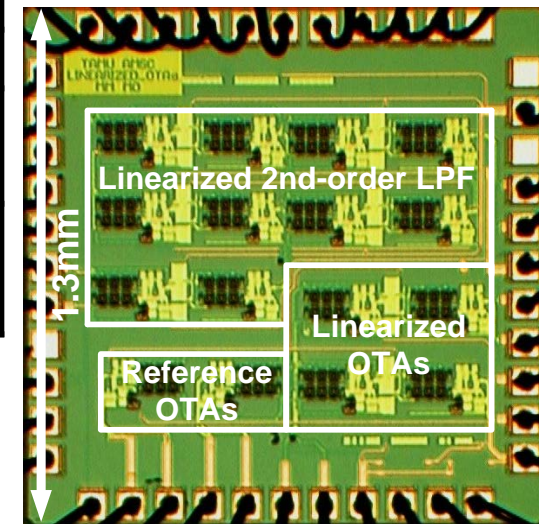
OTA type	Input-referred Noise	IM3 ($V_{in} = 0.2 V_{p-p}$)		
		50 MHz	150 MHz	350 MHz
Reference (input attenuation = 1/3)	13.3 nV/ \sqrt{Hz}	-55.3 dB	-60.0 dB	-58.5 dB
Linearized (attenuation = 1/3 & compensation)	21.8 nV/ \sqrt{Hz}	-77.3 dB	-77.7 dB	-74.2 dB



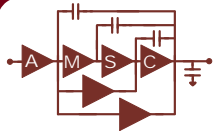
Uncompensated OTA IM3
(input: $0.2V_{p-p}$ @ 350MHz)



Compensated OTA IM3
(input: $0.2V_{p-p}$ @ 350MHz)



Die micrograph
Reference OTA area: 0.033mm²
Linearized OTA area: 0.090mm²



Fully-Differential OTA Comparison With Previous Works



- Figure of Merit [1]:

- FOM = NSNR + 10log(f/1MHz) where:

- NSNR = $SNR_{(dB)} + 10\log[(IM3_N / IM3)(BW / BW_N)(P_N / P_{dis})]$ from [11]

- Normalizations: SNR integrated over 1MHz, $IM3_N = 1\%$, bandwidth $BW_N = 1\text{Hz}$, power $P_N = 1\text{mW}$

- Competitive performance with respect to the state of the art

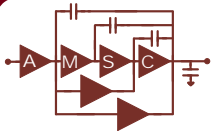
- Effective trade-offs between linearity, power, noise

- Proposed method can also be applied to low-frequency OTAs optimized for low power consumption

	[2]* TCAS I	[3]* JSSC 2006	[4] TCAS I 2006	[5] ISSCC 2001	[6]* ISSCC 2005	This work
IM3	-	-47 dB	-70 dB	-60 dB	-	-74.2 dB
IIP3	-12.5 dBV	-	-	-	7 dBV	14.1 dBV
f	275 MHz	10 MHz	20 MHz	40 MHz	184 MHz	350 MHz
Input voltage	-	0.2 V _{p-p}	1.0 V _{p-p}	0.9 V _{p-p}	-	0.2 V _{p-p}
Power / transconductor	4.5 mW	1.0 mW	4 mW	9.5 mW	1.26 mW	5.2 mW
Input-referred noise	7.8 nV/ $\sqrt{\text{Hz}}$	7.5 nV/ $\sqrt{\text{Hz}}$	70.0 nV/ $\sqrt{\text{Hz}}$	23.0 nV/ $\sqrt{\text{Hz}}$	53.7 nV/ $\sqrt{\text{Hz}}$	21.8 nV/ $\sqrt{\text{Hz}}$
Supply voltage	1.2 V	1.8 V	3.3 V	1.5 V	1.8 V	1.2 V
Technology	65 nm CMOS	0.18 μm CMOS	0.5 μm CMOS	0.18 μm CMOS	0.18 μm CMOS	0.13 μm CMOS
FOM _(dB)	87.5	92.9	96.1	99.1	100	105.6
Normalized FOM **	1.0	3.4	7.1	14.3	17.8	64.3

* Power/transconductor calculated from filter power. Individual OTA characterization results not reported in full.

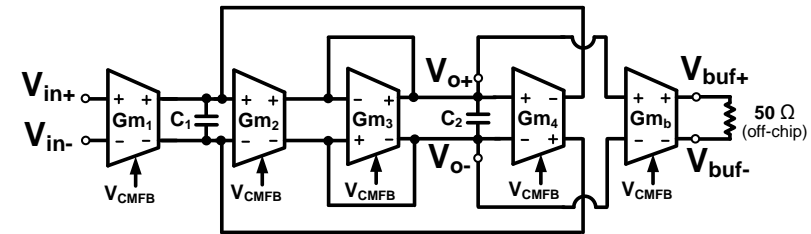
** Normalized FOM magnitude relative to [12]: Normalized |FOM| = $10^{(FOM_{(dB)}/10)} / (10^{(FOM_{(dB)}/10)} \text{ of [12]})$



Measurements: Filter with Linearized OTAs

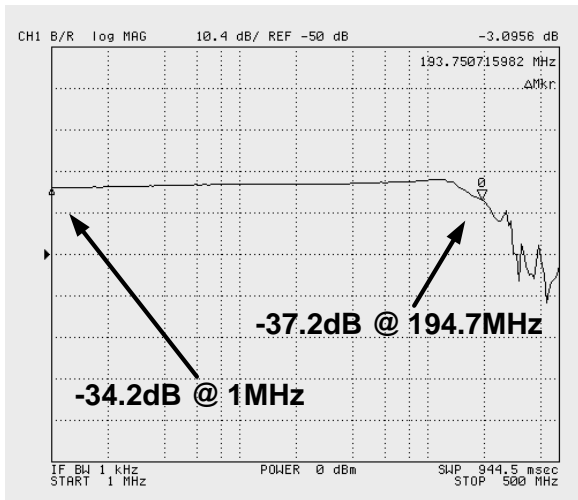
- IM3 is degraded 2-3dB due to non-linearity of output buffer
- $IM3 \approx -70dB$ up to 150MHz for a $0.2V_{p-p}$ two-tone input
- Broadband linearization due to compensation with phase shifter ($IM3$ of $-66.1dB$ at 200MHz, with $f_c = 194.7MHz$)

Parameter	Value
Corner frequency (f_{3db})	194.7 MHz
Passband gain	0 dB
Gain of output buffer ($Gm_b \times 50 \Omega$)	-34.2 dB
$Gm_{1,2,3,4}$	510 $\mu A/V$

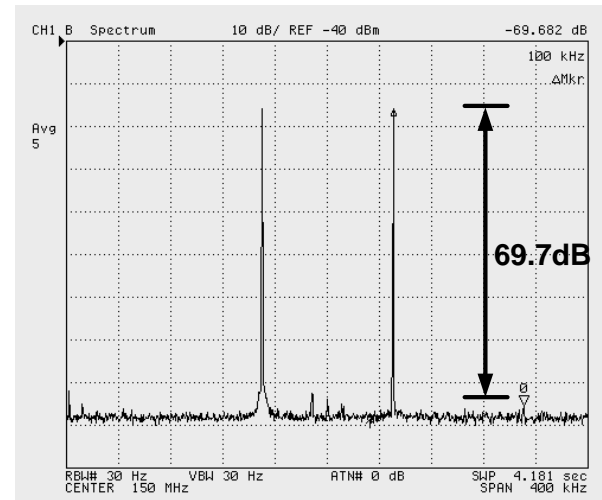


2nd-order low-pass filter diagram & design parameters

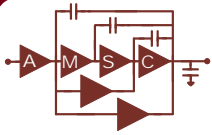
Linearized Filter	IM3 ($V_{in} = 0.2 V_{p-p}$)			
	50 MHz	100 MHz	150 MHz	200 MHz
	-73.9 dB	-69.6 dB	-69.7 dB	-66.1 dB



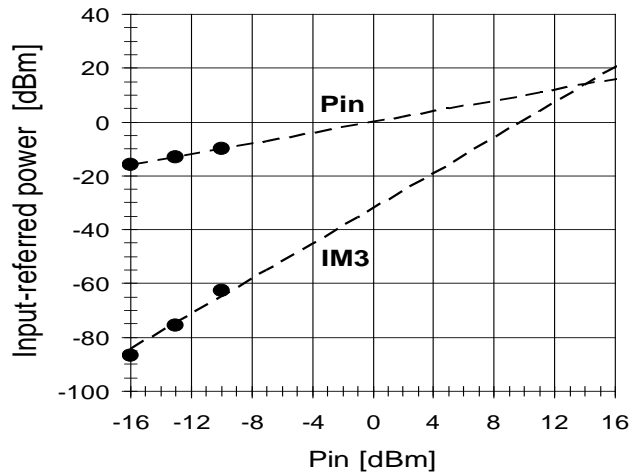
Frequency response of the 2nd - order low-pass filter



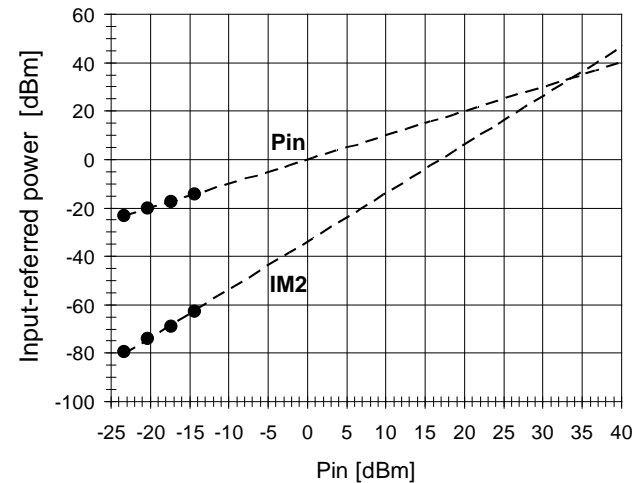
IM3 with compensated OTAs (input: $0.2V_{p-p}$ @ 150MHz)



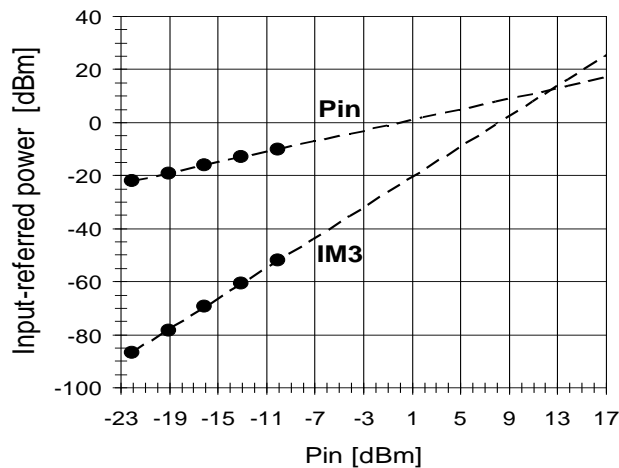
Measurements: Filter with Linearized OTAs



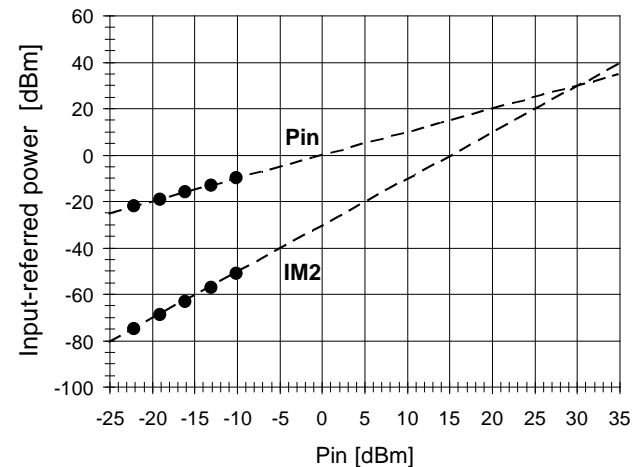
In-band IIP3 (14 dBm)



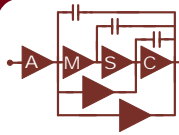
In-band IIP2 (33.7 dBm)



Out-of-band IIP3 (12.4 dBm)



Out-of-band IIP2 (30.4 dBm)

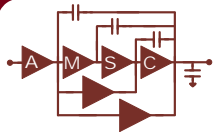


Comparison of wideband Gm-C lowpass filters

	[2]	[6]	[26]	[27]	[28]	[29]	[30]	This work
Filter order	5	5	8	4	7	5	3	2
f_c (max.)	275 MHz	184 MHz	120 MHz	200 MHz	200 MHz	500 MHz	300 MHz	200 MHz
Signal swing	-	0.30 V _{p-p}	0.20 V _{p-p}	0.88 V _{p-p}	0.80 V _{p-p}	0.50 V _{p-p}	-	0.75 V _{p-p}
Linearity with max. Vin _{p-p}	-	HD3, HD5: < -45dB	THD: -50dB @ 120MHz	THD: -40dB @ 20MHz	THD: -42dB @ 200MHz	THD: < -40dB @ 70MHz	-	IM3: -31dB **** @ 150MHz
In-band IIP3	-12.5 dBV (0.5 dBm)	7dBV (20dBm)	-	-	-	-	3.9 dBV (16.9 dBm)	1.0 dBV (14.0 dBm)
In-band IIP2	-	-	-	-	-	-	19 dBV (32 dBm)	20.7 dBV (33.7 dBm)
Out-of-band IIP3	-8 dBV (5 dBm)	-	-	-	-	-	-	-0.6 dBV (12.4 dBm)
Out-of-band IIP2	15 dBV (28 dBm)	-	-	-	-	-	-	17.4 dBV (30.4 dBm)
Power	36 mW	12.6 mW	120 mW	48 mW	210 mW	100 mW	72 mW	20.8 mW
Power per pole	7.2 mW	2.5 mW	15 mW	12 mW	30 mW	20 mW	24 mW	10.4 mW
Input-referred noise	7.8 nV/√Hz	53.7 nV/√Hz**	-	-	-	-	5 nV/√Hz	35.4 nV/√Hz
Dynamic range	44 dB*	43.3 dB***	45 dB	58 dB	-	52 dB	-	54.5 dB***
Supply voltage	1.2 V	1.8 V	2.5 V	2 V	3 V	3.3 V	1.8 V	1.2 V
Technology	65 nm CMOS	0.18 μm CMOS	0.25 μm CMOS	0.35 μm CMOS	0.25 μm CMOS	0.35 μm CMOS	0.18 μm CMOS	0.13 μm CMOS

*Reported spurious-free dynamic range. ** Calculated from $9.3\mu\text{V}_{\text{RMS}}$ in 30kHz BW.

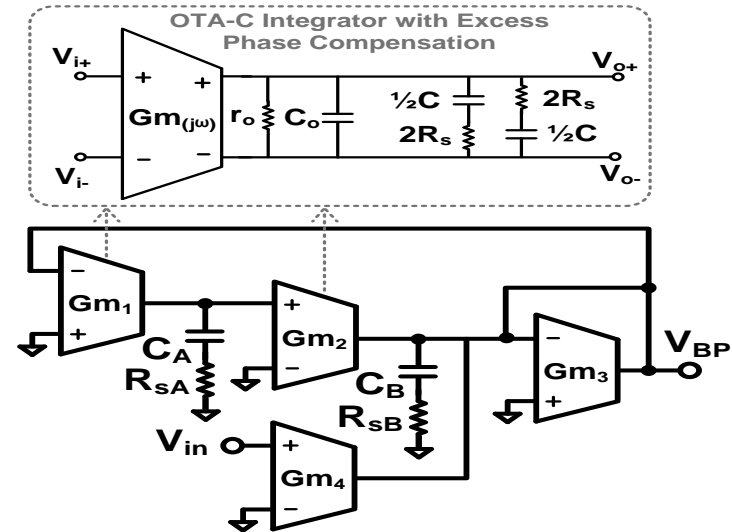
*** Calculated from max. V_{p-p} , f_c , and input-referred noise density. **** IM3 of -31dB measured close to f_c ensures THD < -40dB.



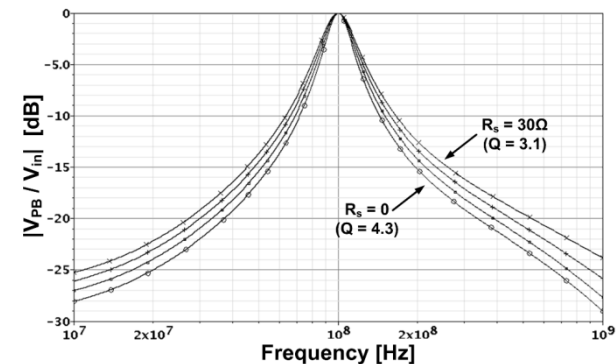
Excess phase compensation



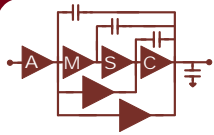
- Linearization introduces a pole that can cause stability problems
- The effect of the pole can be cancelled by adding a series resistance with integrating capacitors
- Poles effect can be partially cancelled in nodes where multiple OTAs are connected together



Single-ended equivalent block diagram of a bandpass biquad



Filter simulations with different R_s values for excess phase compensation



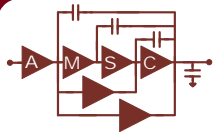
Linearization without power budget increase



- Linearized OTA consumes twice the power of non-linearized OTA
- Linearization can be done while keeping the power the same by dividing the power budget between the main and auxiliary OTA

OTA type	V_{DSAT} of input diff. pair (M_c)	f_{3db} with 50Ω load	Input-referred noise	Power	IM3 ($V_{in} = 0.2 V_{p-p}$)	Normalized $ FOM ^*$ (at f_{max})
Reference (input attenuation = 1/3)	90 mV	2.49 GHz	9.7 nV/ \sqrt{Hz}	2.6 mW	-53.1 dB at $f_{max} = 350MHz$ (-53.2 dB at 100MHz)	57.2
Linearized (attenuation = 1/3 & compensation)	54 mV	1.09 GHz	14.3 nV/ \sqrt{Hz}	2.6 mW	-77.1 dB at $f_{max} = 100MHz$	119.2

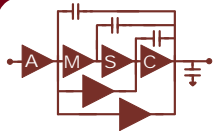
Simulated comparison: OTA linearization without power consumption increase



Summary & Conclusions



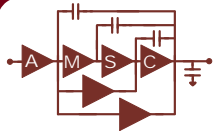
- Proposed attenuation-predistortion technique
 - Effective over a wide frequency band and across PVT variations
 - Independent of OTA circuit topology
 - Allows linearity, noise, power design trade-offs with state of the art performance
 - Compensation for PVT variations are based on digital adjustment of resistors
- Measured performance
 - IM3 improvement of up to 22dB compared to identical reference OTA w/o linearization
 - IM3 as low as -74dB with $V_{in_{p-p}} = 0.2V$ at 350MHz
 - Suitable for filter applications requiring an overall $IM3 \leq -70dB$ up to the cutoff frequency



References

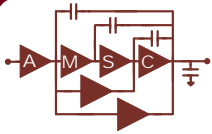


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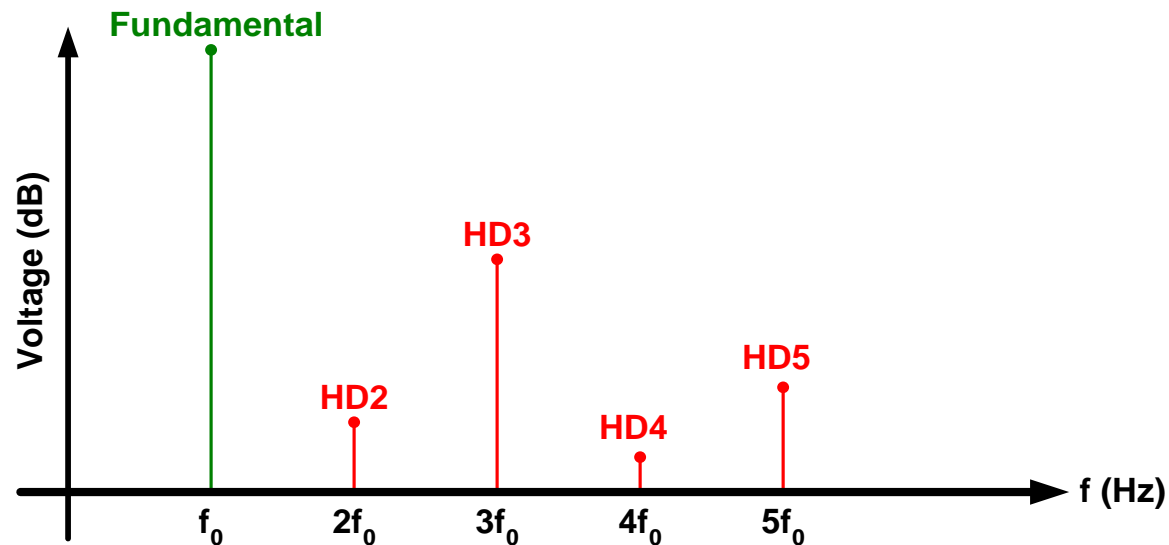
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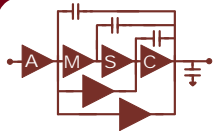
Linearization Basics



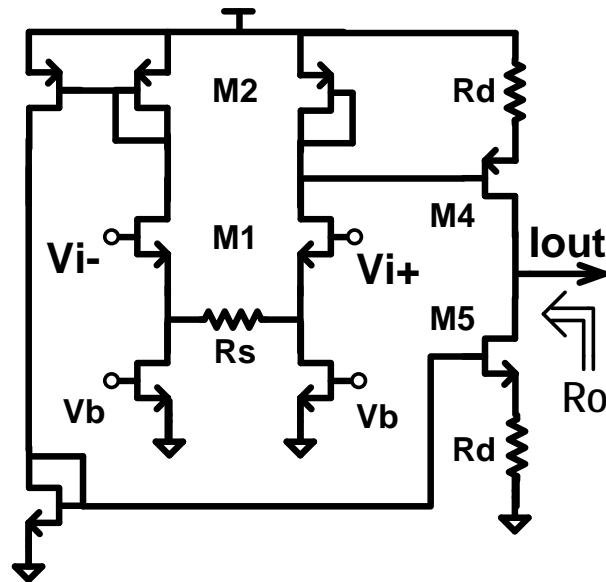
- Linearity Improvement Concepts
 - Effect of odd-order harmonics can be reduced by:
 - ♦ Signal attenuation
 - ♦ Cancellation
 - ♦ Feedback
 - Even-order harmonics are suppressed in fully-differential circuits



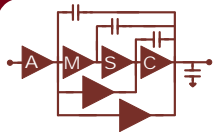
Spectrum for a fully-differential OTA without odd-order cancellation



Single-Ended OTA: Device Dimensions



Component	Design (W/L in μm)
$(W/L)_{M1}$	43.2 / 0.12
$(W/L)_{M2}$	38.4 / 0.24
$(W/L)_{M3}$	11.04 / 0.24
$(W/L)_{M4}$	153.6 / 0.24
$(W/L)_{M5}$	44.16 / 0.24
Rs	250 Ω
Rd	700 Ω
Vdd	1.2V



Single-Ended OTA: Schematic Simulations

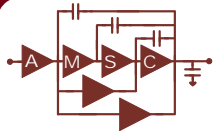


Comparison with $V_{in,p-p} = 200\text{mV}$ @ **100MHz**:

Parameter	Reference OTA	Linearized OTA
$G_{m\text{effective}}$	$G_m/2$	$G_m/2$
THD	1.32% (-37.6dB)	0.048% (-66.8dB)
HD2 (below fundamental)	37.68dB	66.68dB
HD3 (below fundamental)	54.35dB	84.26dB
IM3, $\Delta f=5\text{MHz}$ (below fundamental)	42.8dB	61.9dB
Input-referred noise	17.3nV/ $\sqrt{\text{Hz}}$	27.7nV/ $\sqrt{\text{Hz}}$

Comparison with $V_{in,p-p} = 200\text{mV}$ @ **10MHz**:

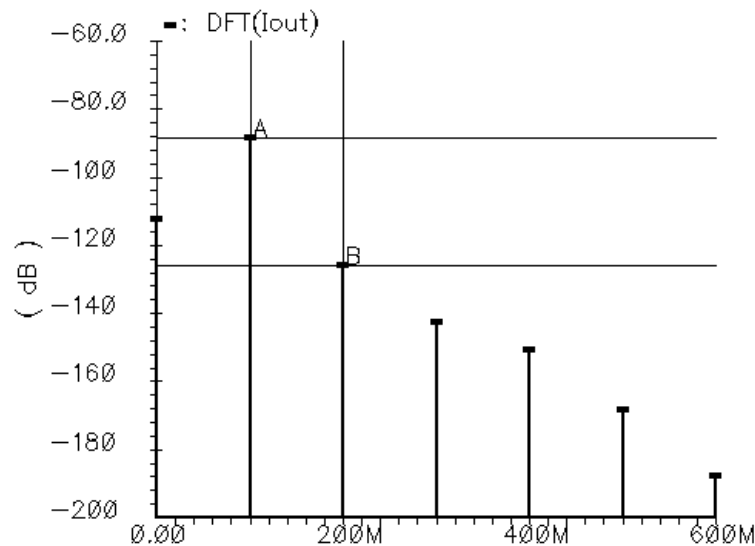
Parameter	Reference OTA	Linearized OTA
$G_{m\text{effective}}$	$G_m/2$	$G_m/2$
THD	1.31% (-37.7dB)	0.021% (-73.6dB)
HD2 (below fundamental)	37.78dB	73.49dB
HD3 (below fundamental)	53.88dB	93.03dB
IM3, $\Delta f=0.5\text{MHz}$ (below fundamental)	42.8dB	67.2dB
Input-referred noise	18.7nV/ $\sqrt{\text{Hz}}$	29.1nV/ $\sqrt{\text{Hz}}$



Single-Ended OTA: HD3 Simulations

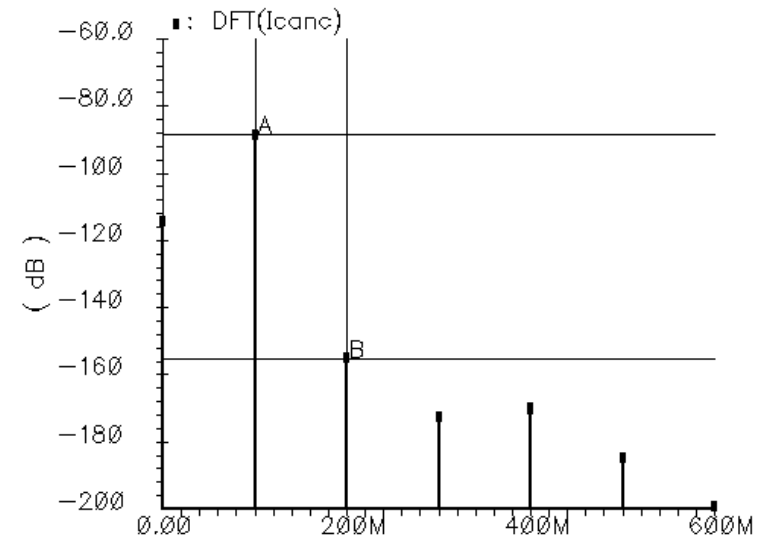


- Output current spectra from HD3 tests
 - $V_{in_{peak-peak}} = 200\text{mV}$



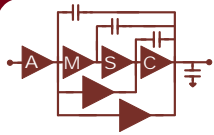
A: (100M -88.2953) delta: (100M -37.6828)
 B: (200M -125.978) slope: -376.828n

OTA with input-attenuation factor of 0.5



A: (100M -88.5363) delta: (100M -66.679)
 B: (200M -155.215) slope: -666.79n

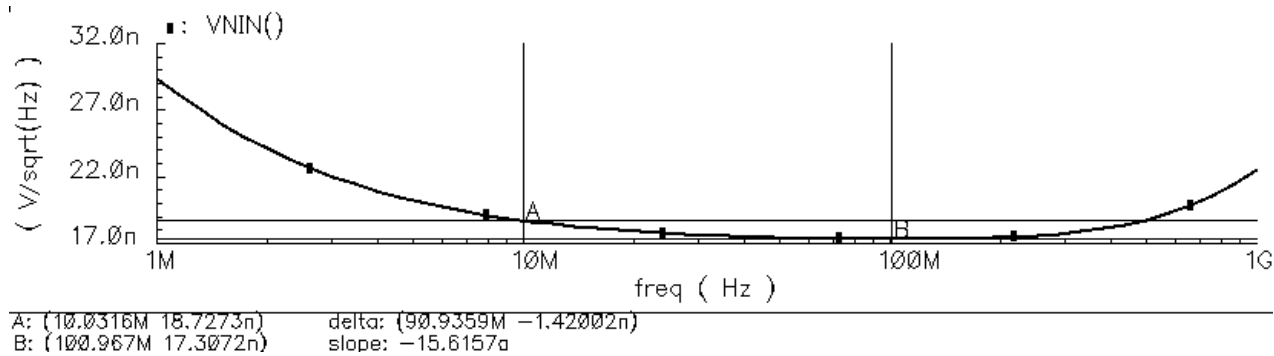
Linearized OTA



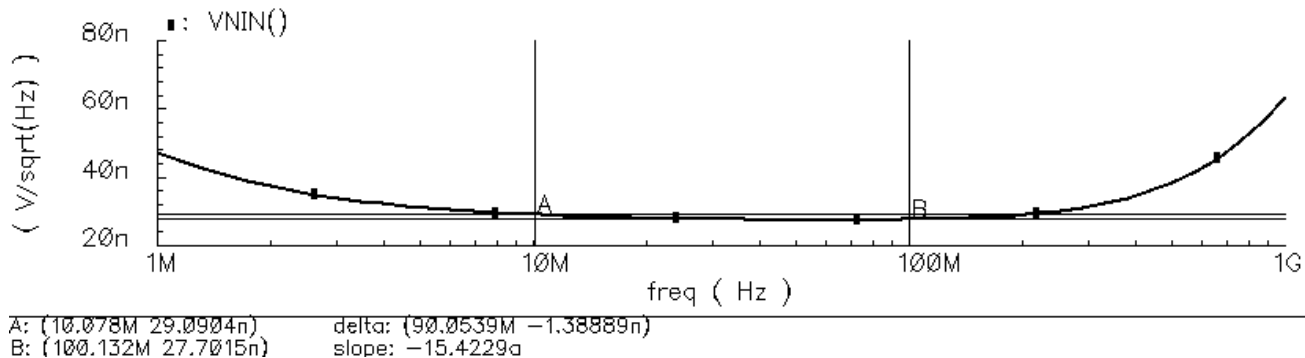
Single-Ended OTA: Noise Simulations



- Input-referred noise of linearized OTA is larger by a factor of ~ 1.6

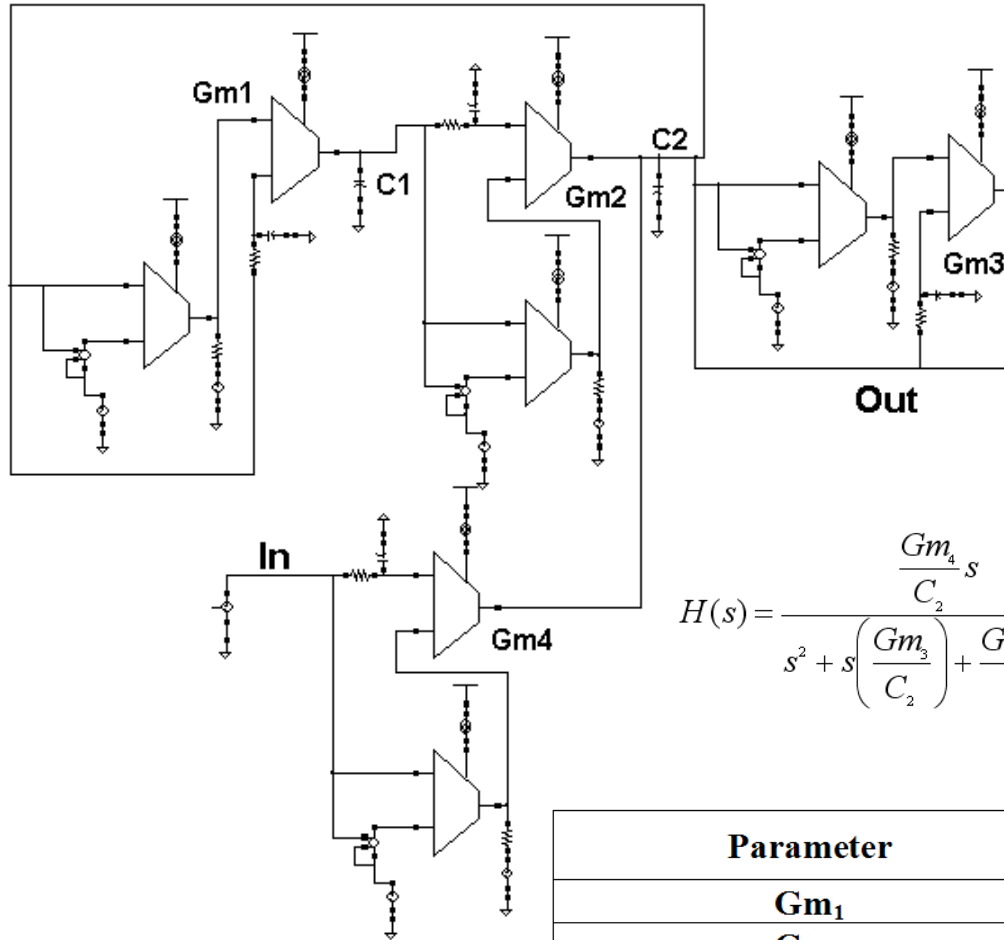
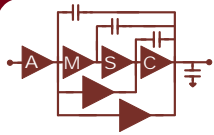


OTA with input-attenuation factor of 0.5



Linearized OTA

Biquad with Single-Ended OTAs

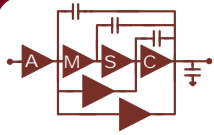


$$H(s) = \frac{\frac{Gm_4}{C_2} s}{s^2 + s \left(\frac{Gm_3}{C_2} \right) + \frac{Gm_1 Gm_2}{C_1 C_2}}$$

$$\omega_0 = \sqrt{\frac{Gm_1 Gm_2}{C_1 C_2}}$$

$$Q = \frac{C_2}{Gm_3} \sqrt{\frac{Gm_1 Gm_2}{C_1 C_2}}$$

Parameter	Reference Filter	Linearized Filter
Gm_1	760 μ A/V	760 μ A/V
Gm_2	760 μ A/V	760 μ A/V
Gm_3	204 μ A/V	435 μ A/V
Gm_4	760 μ A/V	760 μ A/V
C_1	140fF	~117fF (more parasitics)
C_2	400fF	~271fF (more parasitics)



Biquad Simulations with Single-Ended OTAs



Comparison with $V_{in\text{p-p}} = 200\text{mV}$ at 100MHz :

Parameter	Reference OTA	Linearized OTA
$G_{m\text{effective}}$ (OTAs)	$G_m/2$	$G_m/2$
f_0	100MHz	100MHz
Q	2	~ 2
$A_{v\text{passband}}$	1.91dB	1.77dB
$V_{o\text{p-p}}$	232mV	241mV
THD	3.144% (-30.1dB)	0.212% (-53.5dB)
HD2 (below fundamental)	30.08dB	53.85dB
HD3 (below fundamental)	53.45dB	64.57dB